

ADVANCED MIRROR SYSTEM DEMONSTRATOR (AMSD)

AMBIENT AND CRYOGENIC TEST PLANS

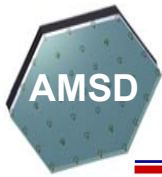
AT

GOODRICH ELECTRO-OPTICAL SYSTEMS

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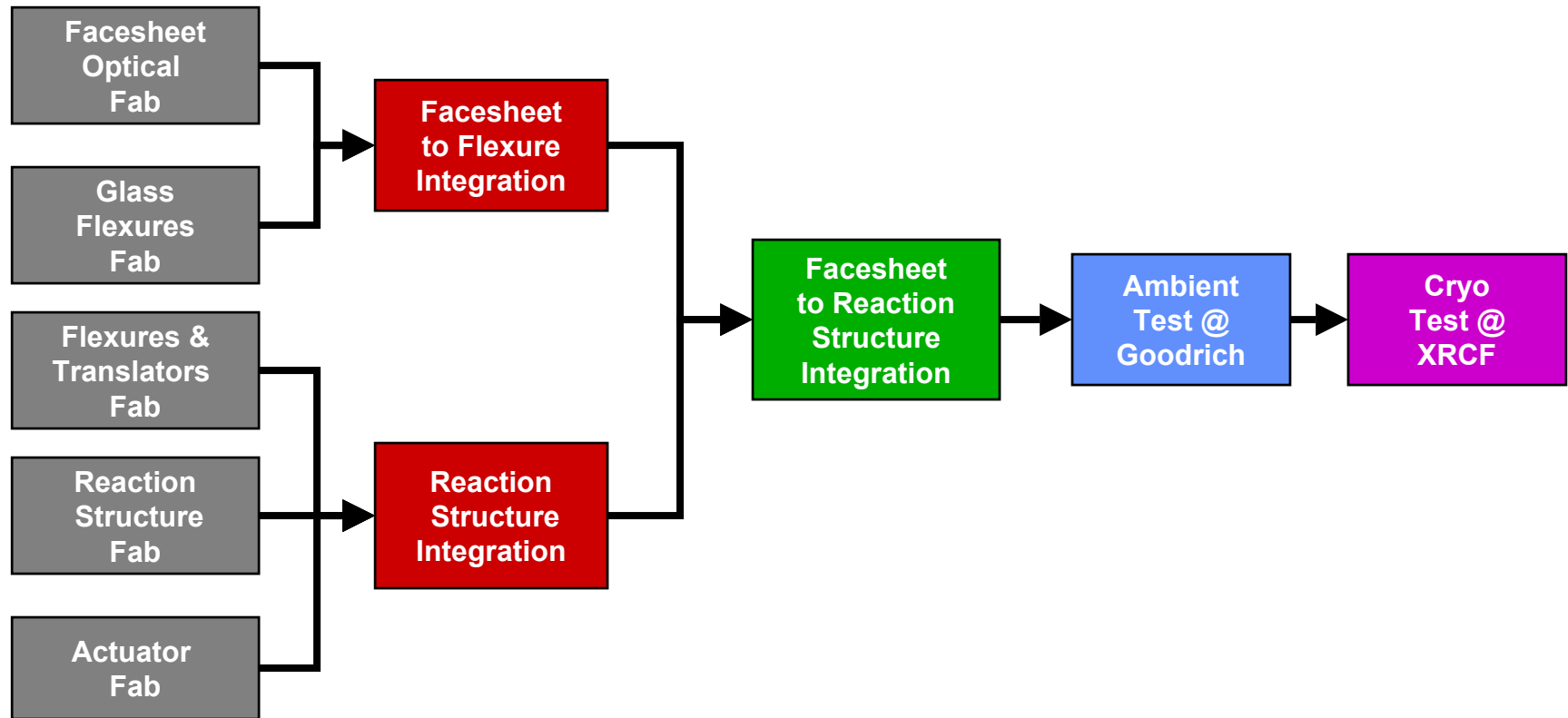
NASA Technology Days
Marshall Space Flight Center
May 22-23, 2002

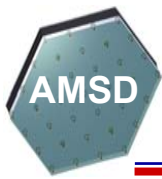


Process Flow Summary



VG H26-0068 52

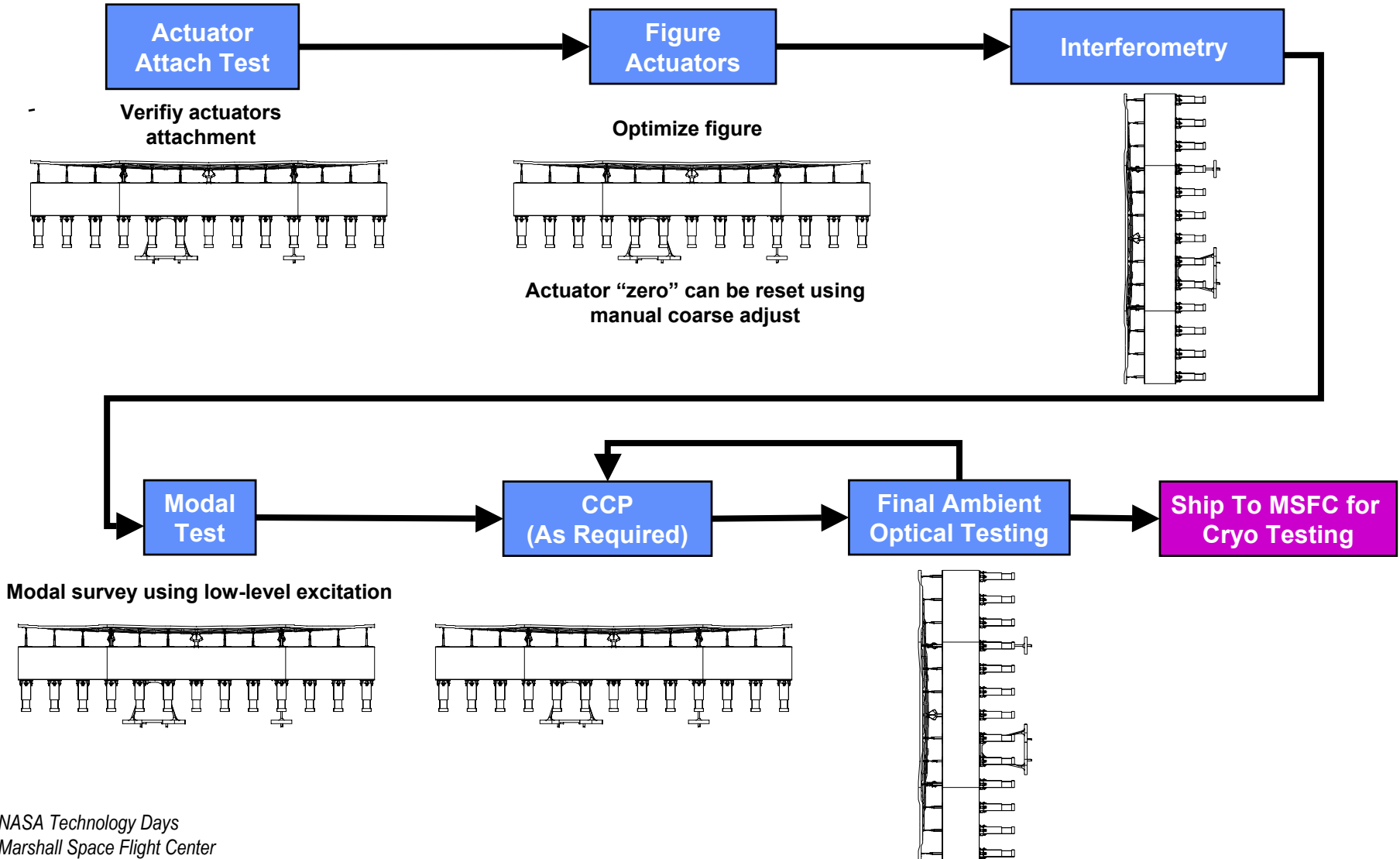


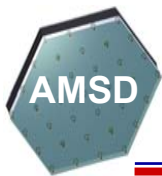


Test & Verification (RT at Goodrich)



VG H26-0068 53

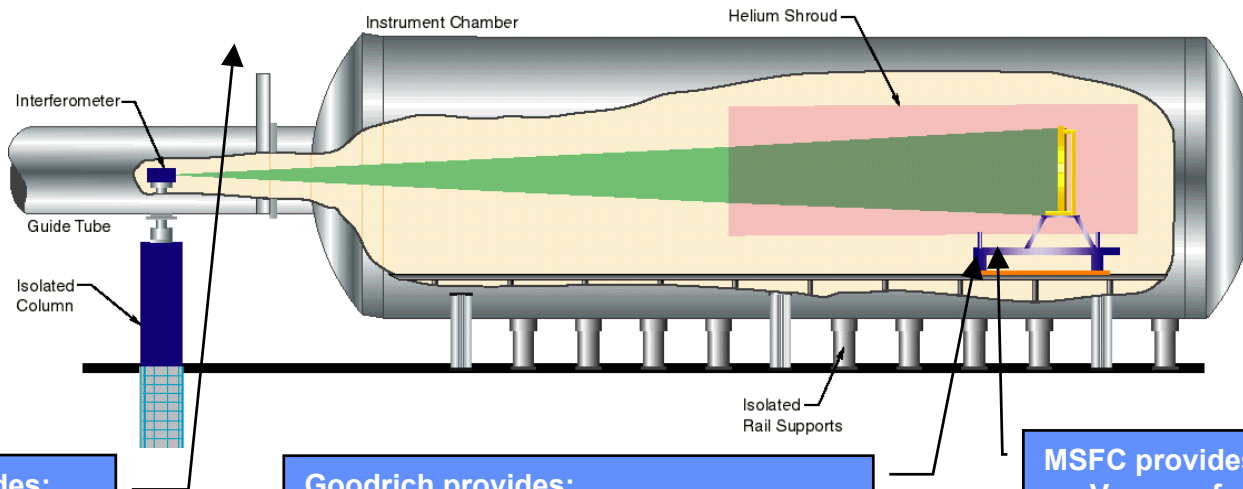




Cryo Test Arrangements at the XRCF



VG H26-0068 54



MSFC provides:

- Interferometer
- Objective Lens
- Leica ADM
- Window
- DNC

Goodrich provides:

- In-chamber cabling for actuators & temp. sensors
- Out-chamber cabling for actuators
- Mirror Assembly temp. sensors
- Actuator Control Electronics & PC

MSFC provides:

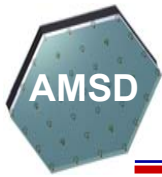
- Vacuum feedthroughs
- Cabling to control room
- Temp. sensor's readouts
- 5 DOF positioning table

- Establish ambient baseline alignment
- Measure ambient baseline figure

Partially cool chamber

- Measure figure
- Adjust figure actuators as required to minimize figure error
- Track actuator and despace changes over temperature range

- Measure figure at cryogenic operating temperature



• Ambient at Goodrich

- Install and align test article
- Verify software and electronic functionality
- Manual figure correction
 - Visual
- Determine noise levels (OPD, influence functions)
- Influence function measurement
- Optimize figure
 - Use measured influence functions
- Initial data reduction
 - Document results
- Pack and ship to MSFC

• Ambient and Cryo at MSFC

- Install and align test article
- Check out interferometer and software and electrical Interfaces
- Room temperature characterization as done at Goodrich
- Radius of curvature monitoring throughout
- Cryo Test
 - Cool down, adjusting figure intermittently as needed
 - At cryo:
 - Check actuator functionality
 - Manually optimize figure
 - Measure influence functions & associated noise
 - Optimize figure
 - Actuator/influence function characterization measurements
 - Return to RT, adjusting figure intermittently as needed
- Remove test article



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